



# **Description**

The IRFR9024NTRPBF uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

# TO-252-2L (TO-252-2(DPAK))

### **General Features**

 $V_{DS} = -60V I_{D} = -10 A$ 

 $R_{DS(ON)}$  < 140m $\Omega$  @  $V_{GS}$ =10V

# **Application**

Brushless motor

Load switch

Uninterruptible power supply

P-Channel MOSFET

# **Package Marking and Ordering Information**

Product ID	Pack	Marking	Qty(PCS)	
IRFR9024NTRPBF	TO-252-2L(TO-252-2(DPAK))	10P06 XXYY	2500	

# Absolute Maximum Ratings (T<sub>c</sub>=25<sup>o</sup>Cunless otherwise noted)

Symbol	Parameter	Rating	Units	
Vos	Drain-Source Voltage -60		V	
Vgs	Gate-Source Voltage ±20		V	
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-10	Α	
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup> -8.3		А	
I <sub>D</sub> @T <sub>A</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-3.3	А	
I <sub>D</sub> @T <sub>A</sub> =70°C	Continuous Drain Current, V <sub>GS</sub> @ -10V <sup>1</sup>	-2.7	А	
Ірм	Pulsed Drain Current <sup>2</sup>	-26	А	
EAS	Single Pulse Avalanche Energy <sup>3</sup>	29.8	mJ	
las	Avalanche Current	-24.4	Α	
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>4</sup>	31.3	W	
P <sub>D</sub> @T <sub>A</sub> =25°C	Total Power Dissipation <sup>4</sup>	2	W	
Тѕтс	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	-55 to 150	°C	
R <sub>θ</sub> JA	Thermal Resistance Junction-Ambient <sup>1</sup>	62	°C/W	
R <sub>θ</sub> JC	Thermal Resistance Junction-Case <sup>1</sup>	4.0	°C/W	

# P-Channel Enhancement Mode MOSFET

# P-Channel Electrical Characteristics (TJ =25 ℃, unless otherwise noted)

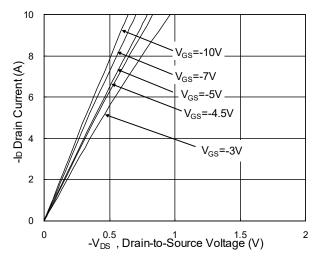
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA	-60			V	
∆BVDSS/∆TJ	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =-1mA		-0.03		V/°C	
RDS(ON)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =-10V , I <sub>D</sub> =-3A		125	140	mΩ	
NBO(ON)	Static Dialii-Source On-Nesistance	V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-2A	185 200		11122		
VGS(th)	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D$ =-250uA	-1.2	1.6	-2.5	<b>V</b>	
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =-48V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1	uA	
1033		V <sub>DS</sub> =-48V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C			5		
IGSS	Gate-Source Leakage Current	$V_{GS}$ =±20 $V$ , $V_{DS}$ =0 $V$			±100	nA	
gfs	Forward Transconductance	V <sub>DS</sub> =-5V , I <sub>D</sub> =-3A		8.5		S	
Qg	Total Gate Charge (-4.5V)			12.1			
Qgs	Gate-Source Charge	V <sub>DS</sub> =-48V , V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-3A		2.2		nC	
Qgd	Gate-Drain Charge			6.3			
Td(on)	Turn-On Delay Time			9.2		- ns	
Tr	Rise Time	V <sub>DD</sub> =-15V , V <sub>GS</sub> =-10V , R <sub>G</sub> =3.3□,		20.1			
Td(off)	Turn-Off Delay Time	I <sub>D</sub> =-1A		46.7			
Tf	Fall Time			9.4			
Ciss	Input Capacitance			1137			
Coss	Output Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz		76		pF	
Crss	Reverse Transfer Capacitance			50			
IS	Continuous Source Current <sup>1,5</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-13	Α	
VSD	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C			-1.2	V	

# Note:

- 1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- $2\sqrt{100}$  The data tested by pulsed , pulse width  $\leq 300$ us , duty cycle  $\leq 2\%$
- 3. The EAS data shows Max. rating . The test condition is V DD =-25V,V GS =-10V,L=0.1mH,IAS =-24A
- 5. The data is theoretically the same as I D and I DM, in real applications, should be limited by total power dissipation.



# **P-Channel Typical Characteristics**



**Fig.1 Typical Output Characteristics** 

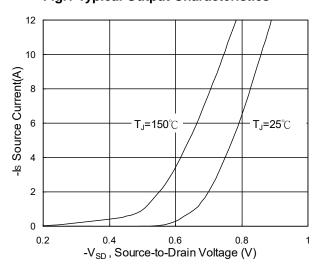


Fig.3 Forward Characteristics of Reverse

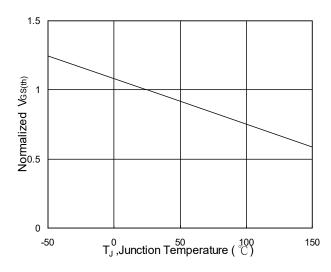


Fig.5 Normalized  $V_{GS(th)}$  v.s  $T_J$ 

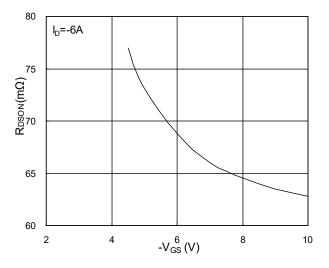


Fig.2 On-Resistance v.s Gate-Source

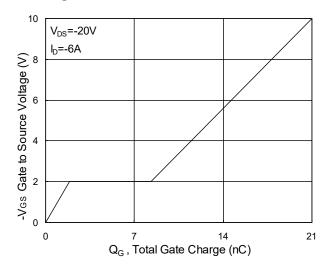


Fig.4 Gate-Charge Characteristics

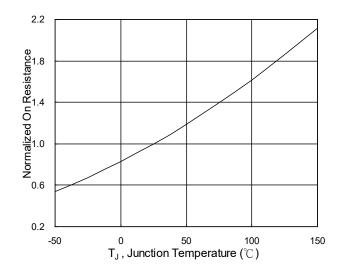
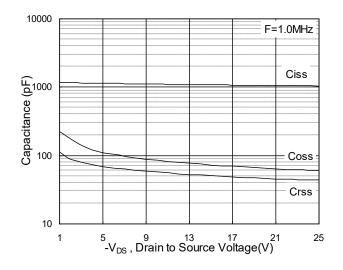


Fig.6 Normalized  $R_{DSON}$  v.s  $T_J$ 



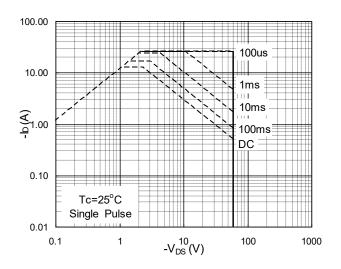


Fig.7 Capacitance

Fig.8 Safe Operating Area

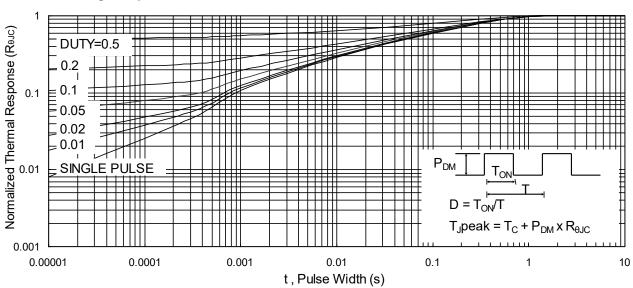


Fig.9 Normalized Maximum Transient Thermal Impedance

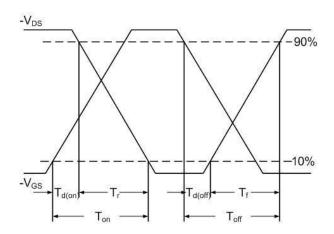


Fig.10 Switching Time Waveform

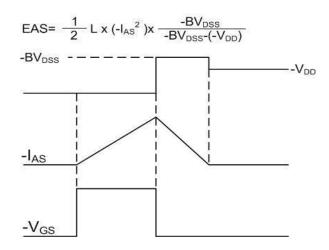
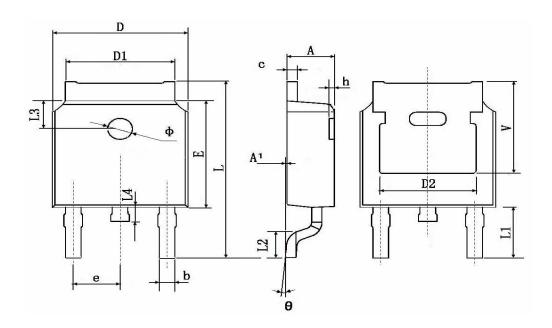


Fig.11 Unclamped Inductive Switching Waveform

# P-Channel Enhancement Mode MOSFET

# TO-252-2L(TO-252-2(DPAK)) Package Information



Dimensions In Millimeters		Dimensions In Inches		
Min.	Max.	Min.	Max.	
2.200	2.400	0.087	0.094	
0.000	0.127	0.000	0.005	
0.660	0.860	0.026	0.034	
0.460	0.580	0.018	0.023	
6.500	6.700	0.256	0.264	
5.100	5.460	0.201	0.215	
4.830 TYP.		0.190 TYP.		
6.000	6.200	0.236	0.244	
2.186	2.386	0.086	0.094	
9.800	10.400	0.386	0.409	
2.900 TYP.		0.114 TYP.		
1 400	1 700	0.055	0.067	
1.600 TYP.		0.063 TYP.		
0.600	1.000	0.024	0.039	
1.100	1.300	0.043	0.051	
0°	8°	0°	8°	
0.000	0.300	0.000	0.012	
5.350	TYP.	0.211 TYP.		
	Min. 2.200 0.000 0.660 0.460 6.500 5.100 4.830 6.000 2.186 9.800 2.900 1.400 1.600 0.600 1.100 0° 0.000	Min.         Max.           2.200         2.400           0.000         0.127           0.660         0.860           0.460         0.580           6.500         6.700           5.100         5.460           4.830 TYP.         6.200           2.186         2.386           9.800         10.400           2.900 TYP.         1.700           1.600 TYP.         0.600           1.100         1.300           0°         8°	Min.         Max.         Min.           2.200         2.400         0.087           0.000         0.127         0.000           0.660         0.860         0.026           0.460         0.580         0.018           6.500         6.700         0.256           5.100         5.460         0.201           4.830 TYP.         0.190           6.000         6.200         0.236           2.186         2.386         0.086           9.800         10.400         0.386           2.900 TYP.         0.114           1.400         1.700         0.055           1.600 TYP.         0.063           0.600         1.000         0.024           1.100         1.300         0.043           0°         8°         0°           0.000         0.300         0.000	

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